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2rc	AA	6	1	1 6 7 9 5 2		2	Jan. 2, 2001	Downing	165	167				
	AB	6	0	0	5	7	7	2	Dec. 21, 1999	Terao et al.	361	699		
	AC	5	8	3	6	3	8	3	Nov. 17, 1998	Zwittig	165	167		
-	AD	5	8	3	5	3	4	5	Nov. 10, 1998	Staskus et al.	361	699	V .	
	ΑE	5	7	2	7	7 6 1 8			Mar. 17, 1998	Mundinger et al.	165	80.4		
	AF	5	4	2	9 1 8 3				Jul. 4, 1995	Hisamori et al.	165	134.1	<del></del>	
	AG	5	1	4	5	0	0	1	Sep. 8, 1992	Valenzuela	165	164		
	АН	5	0	8	8	0	0	5	Feb. 11, 1992	Ciaccio	361	385		
	AI	5	0	2	9	6	3	8	Jul. 9, 1991	Valenzuela	165	164		
	AJ	5	0	1	6	7 0 7			May 21, 1991	Nguyen	165	167		
	AK	4	8	8	0	0 5 5			Nov. 14, 1989	Niggemann et al.	165	167		
	AL	4	4	9	4	1	7	1	Jan. 15, 1985	Bland et al.	361	386		
	AM	4	4	5	0	4	7	2	May 22, 1984	Tuckerman et al.	357	82		
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	АН	Y. N Coo	Microelectromechanical Systems, Vol. 10, No. 2, June 2001, pp. 222-231.  Y. Murakami & B.B. Mikic, "Parametric Optimization of Multichanneled Heat Sinks for VLSI Chip Cooling", IEEE Transactions on Components and Packaging Technologies, Vol. 24, No. 1, March 2001,												
	Al		iang,					rced Convection Boiling ol. 10, No. 1, March 2001		annel Heat Sink'	', Journal of				
	AJ	J. D	arab	i, M.M	I. Oha	adi & D. De'	Voe	, "An Electrohydrodynam	ic Polarization	• •					
	AK	C. P Coo	Cooling", Journal of Microelectromechanical Systems, Vol. 10, No. 1, March 2001, pp. 98-106.  C. Perret, J. Boussey, C. Schaeffer & M. Coyaud, "Analytic Modeling, Optimizing, and Realization of Cooling Devices in Silicon Technology", IEEE Transactions on Components and Packaging Technologies, Vol. 23, No. 4, December 2000, pp. 665-672.												
	AL	D. (	Cope	land, "	Mani	fold Microc	hanı	nel Heat Sinks: Analysis a	and Optimiza	tion", ASME/JS	ME Thermal				
	AM	D. C	Engineering Conference: Volume 4, 1995, pp. 169-174.  D. Copeland, H. Takahira, W. Nakayama & B. Pak, "Manifold Microchannel Heat Sinks: Theory and Experiment", Advances in Electronic Packing, EEP-Vol. 10-2, 1995, pp. 829-835.												
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NC	AD	5	3	0	9	3	1	9	May 3, 1994	Messina 💥	361	699		
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